## LICENSEE EVENT REPORT

	CONTROL BLOCK: (PLEASE PRINT OR TYPE ALL REQUIRED INFORMATION)
0 1	N C B E P 2 2 0 0 - 0 0 0 0 - 0 0 3 4 1 1 1 1 4 5 5 LICENSE CODE 14 15 LICENSE NUMBER 25 26 LICENSE TYPE 30 57 CAT 58
0 1 7 8	SOURCE LL 6 0 5 0 - 0 3 2 4 7 0 7 2 7 8 1 8 0 8 1 0 8 1 0 8 1 9
0 2	During a reactor startup it was discovered that control rod 34-19 had continuous
03	"full-in" RTGB position indication regardless of actual rod position. The rod was
0 4	then bypassed in the Rod Sequence Control System in accordance with technical speci-
	fications. This event did not affect the health and safety of the public.
0 5	
0 6	
0 7	makainal Canaifications 3 1 3 7 6 9 1 9h
0 8	Technical Specifications 3.1.3.7, 6.9.1.9b  SYSTEM CAUSE CAUSE COMP. VALVE
0 9	CODE CODE SUBCODE SUBC
	17 REPORT NUMBER 21 22 23 24 26 27 28 29 30 31 32
	ACTION FUTURE TAKEN ACTION ON PLANT SHUTDOWN METHOD HOURS 22 ATTACHMENT FORM SUB. SUPPLIER MANUFACTURER  A 18 Z 19 Z 20 Z 21 0 0 0 0 0 Y 23 Y 24 N 25 G 0 8 0 26
1 0	CAUSE DESCRIPTION AND CORRECTIVE ACTIONS (27)  Transistor Q16, model number 2N3417, and integrated circuit G33, model number
111	176A1664P936, located on the rod position indication system probe buffer card failed
112	due to apparent end of life and caused the indication problem. The transistor and
	the circuit were replaced and the rod position indication returned to normal. No
	further corrective action to this event is required.
7 8	9 80 METHOD OF (32)
1 5	STATUS SPOWER OTHER STATUS OF DISCOVERY DESCRIPTION GET DISCOVERY DISCOVERY DESCRIPTION GET DISCOVERY DISCOVERY DESCRIPTION GET DISCOVERY DI
16	ACTIVITY CONTENTER AMOUNT OF ACTIVITY (35)  LZ (33) LZ (34) NA LOCATION OF RELEASE (36)  NA LOCATION OF RELEASE (36)  NA LOCATION OF RELEASE (36)
1 7	PERSONNEL EXPOSURES NUMBER TYPE DESCRIPTION (39)  NA
7 8	9 PERSONNEL INJURIES NUMBER DESCRIPTION (41)
1 8	0 0 0 0 0 0 NA 80
1 0	LGSS OF OR DAMAGE TO FACILITY (43) TYPE DESCRIPTION NA
1	9 10 AND DESCRIPTION AND DESCR
2 0	NA PDR ADOCK 05000324
	NAME OF PREPARER M. J. Pastva, Jr. PHONE 919-457-9521

LER ATTACHMENT - RO #2-81-64

Facility: BSEP Unit No. 2 Event Date: 7-27-81

The failures of transistor Q16 and the integrated circuit G33 of the probe buffer card for rod 34-19 do not constitute a safety hazard and are expected on an occasional basis. Therefore, whenever these type failures do occur and are determined to have resulted from natural end of component life, they will be repaired as required.